SN54ABT16540, SN74ABT16540A 16-BIT BUFFERS/DRIVERS WITH 3-STATE OUTPUTS

SCBS208C - FEBRUARY 1991 - REVISED APRIL 1997

SN54ABT16540... WD PACKAGE SN74ABT16540A... DGG, DGV, OR DL PACKAGE

(TOP VIEW)

- Members of the Texas Instruments *Widebus*™ Family
- State-of-the-Art *EPIC-IIB*[™] BiCMOS Design Significantly Reduces Power Dissipation
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Typical V_{OLP} (Output Ground Bounce)
 < 1 V at V_{CC} = 5 V, T_A = 25°C
- Distributed V_{CC} and GND Pin Configuration Minimizes High-Speed Switching Noise
- Flow-Through Architecture Optimizes PCB Layout
- High-Drive Outputs (–32-mA I_{OH}, 64-mA I_{OL})
- Package Options Include Plastic 300-mil Shrink Small-Outline (DL), Thin Shrink Small-Outline (DGG), and Thin Very Small-Outline (DGV) Packages, and 380-mil Fine-Pitch Ceramic Flat (WD) Package Using 25-mil Center-to-Center Spacings

description

The SN54ABT16540 and SN74ABT16540A are inverting 16-bit buffers/drivers composed of two 8-bit sections with separate output-enable gates. These buffers and bus drivers provide a high-performance bus interface for wide data paths.

The 3-state control gate is a 2-input AND gate with active-low inputs so that if either output-enable $(\overline{OE1} \text{ or } \overline{OE2})$ input is high, all corresponding outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN54ABT16540 is characterized for operation over the full military temperature range of -55° C to 125° C. The SN74ABT16540A is characterized for operation from -40° C to 85° C.



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10E1	$_{1}$ \cup	48 10E2
1Y1 🛛	2	47 🛛 1A1
1Y2	3	46 0 1A2
gnd [4	45 GND
1Y3 [5	44 1A3
1Y4 [43 1A4
v _{cc} [7	42 V _{CC}
1Y5	8	41 145
1Y6	-	40 1A6
	10	39 GND
1Y7 [38 1A7
1Y8		37 A 1A8
2Y1	13	36 2A1
-	14	35 2A1
2Y2		
GND	15	34 GND
2Y3	16	33 2A3
2Y4	17	32 2A4
	18	
2Y5		30 2A5
2Y6	20	29 2A6
GND	21	28 GND
2Y7	22	27 2A7
2Y8	23	26 2A8

25 20E2

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SN54ABT16540, SN74ABT16540A **16-BIT BUFFERS/DRIVERS** WITH 3-STATE OUTPUTS SCBS208C - FEBRUARY 1991 - REVISED APRIL 1997

FUNCTION TABLE (each 8-bit section)									
	INPUTS		OUTPUT						
OE1	OE2	Α	Y						
L	L	L	Н						
L	L	Н	L						
Н	Х	Х	Z						

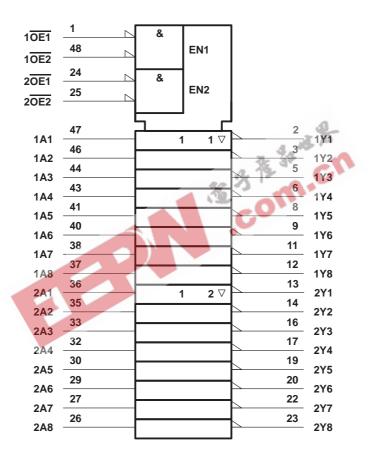
Х

Х

Н

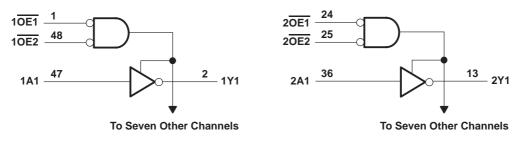
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logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)





absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	
Input voltage range, V _I (see Note 1)	
Voltage range applied to any output in the high or power-off state, V _O	–0.5 V to 5.5 V
Current into any output in the low state, I _O : SN54ABT16540	96 mA
SN74ABT16540A	128 mA
Input clamp current, I _{IK} (V _I < 0)	–18 mA
Output clamp current, I _{OK} (V _O < 0)	
Package thermal impedance, θ_{JA} (see Note 2): DGG package	
DGV package	
DL package	
Storage temperature range, T _{stg}	–65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51.

recommended operating conditions (see Note 3)

			3 St.	SN54AB	T16540	SN74ABT	16540A	LINUT
			~ 3 T	MIN	MAX	MIN	MAX	UNIT
V _{CC}	Supply voltage		132	4.5	5.5	4.5	5.5	V
VIH	High-level input voltage		C	2	EW	2		V
VIL	Low-level input voltage	<u>``</u>			0.8		0.8	V
VI	Input voltage			0 🤇	Vcc	0	VCC	V
ЮН	High-level output current				-24		-32	mA
IOL	Low-level output current			202	48		64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate		Outputs enabled	2	10		10	ns/V
TA	Operating free-air temperature				125	-40	85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.



electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		Т	T _A = 25°C			Г16540	SN74ABT1	UNIT		
PARA	MEIER	IESI CO	MIN TYP [†] MAX				MIN	MAX	MIN MAX		UNIT	
VIK		V _{CC} = 4.5 V,	I _I = -18 mA			-1.2		-1.2		-1.2	V	
		V _{CC} = 4.5 V,	I _{OH} = -3 mA	2.5			2.5		2.5			
Vari		V _{CC} = 5 V, V _{CC} = 4.5 V	I _{OH} = -3 mA	3			3		3		V	
VOH			I _{OH} = -24 mA	2			2				v	
		VCC = 4.5 V	I _{OH} = -32 mA	2*					2			
VOL		V _{CC} = 4.5 V	I _{OL} = 48 mA			0.55		0.55			V	
VOL		VCC = 4.5 V	I _{OL} = 64 mA			0.55*				0.55	v	
V _{hys}					100						mV	
Ц		V _{CC} = 5.5 V,	$V_I = V_{CC} \text{ or } GND$			±1		±1		±1	μΑ	
IOZH		V _{CC} = 5.5 V,	$V_{O} = 2.7 V$			10		50		10	μΑ	
IOZL		V _{CC} = 5.5 V,	$V_{O} = 0.5 V$			-10		-50		-10	μΑ	
loff		$V_{CC} = 0,$	V_I or $V_O \leq 4.5~V$			±100	5	ζ		±100	μΑ	
ICEX		V _{CC} = 5.5 V, V _O = 5.5 V	Outputs high			50	A A A	50		50	μA	
10‡		V _{CC} = 5.5 V,	V _O = 2.5 V	-50	-100	-180	-50	-180	-50	-180	mA	
		V _{CC} = 5.5 V,	Outputs high		38.	3	-	2		3		
ICC		$I_{O} = 0,$	Outputs low		12	34		32		34	mA	
		$V_{I} = V_{CC} \text{ or } GND$	Outputs disabled			3		2		3		
	Data	V _{CC} = 5.5 V, One input at 3.4 V,	Outputs enabled			1		1		1		
∆ICC§	inputs	Other inputs at V _{CC} or GND	Outputs disabled			0.05		0.05		0.05	mA	
	Control inputs	$V_{CC} = 5.5 V$, One in Other inputs at V_{CC}				1.5		1.5		1.5		
Ci		V _I = 2.5 V or 0.5 V			3.5						pF	
Co		$V_0 = 2.5 \text{ V or } 0.5 \text{ V}$			7.5						pF	

* On products compliant to MIL-PRF-38535, this parameter does not apply.

[†] All typical values are at $V_{CC} = 5 V$.

[‡]Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

\$ This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND.

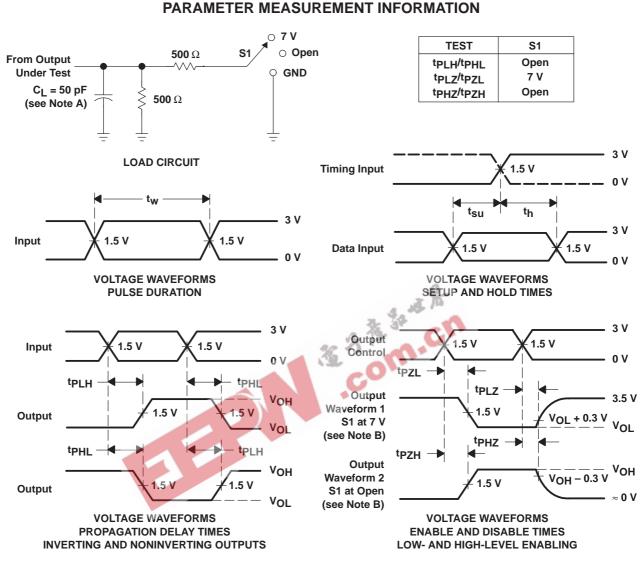
switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER FROM (INPUT) (TO (OUTPUT)	V _{CC} = 5 V, T _A = 25°C			SN54ABT16540		SN74ABT16540A		UNIT	
			MIN	TYP	MAX	MIN	MAX	MIN	MAX		
^t PLH	А	v	1	2.3	3.3	1	4.2	1	4.1	ns l	
^t PHL	A	Ť	1.1	2.5	4.1	1.1	4.4	1.1	4.3		
^t PZH	OE	V	1.1	3.1	4.2	1.1	5.2	1.1	5.1	ns	
^t PZL		Т	1.6	3.7	4.8	1.6	6	1.6	5.9	115	
^t PHZ	OE	v	1.6	4	5	0.6	5.4	1.6	5.7	-	
tPLZ	UE	UE	T	1.4	3.2	4.4	Q 1.4	4.7	1.4	4.7	ns

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NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_Q = 50 Ω , t_f \leq 2.5 ns. t_f \leq 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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